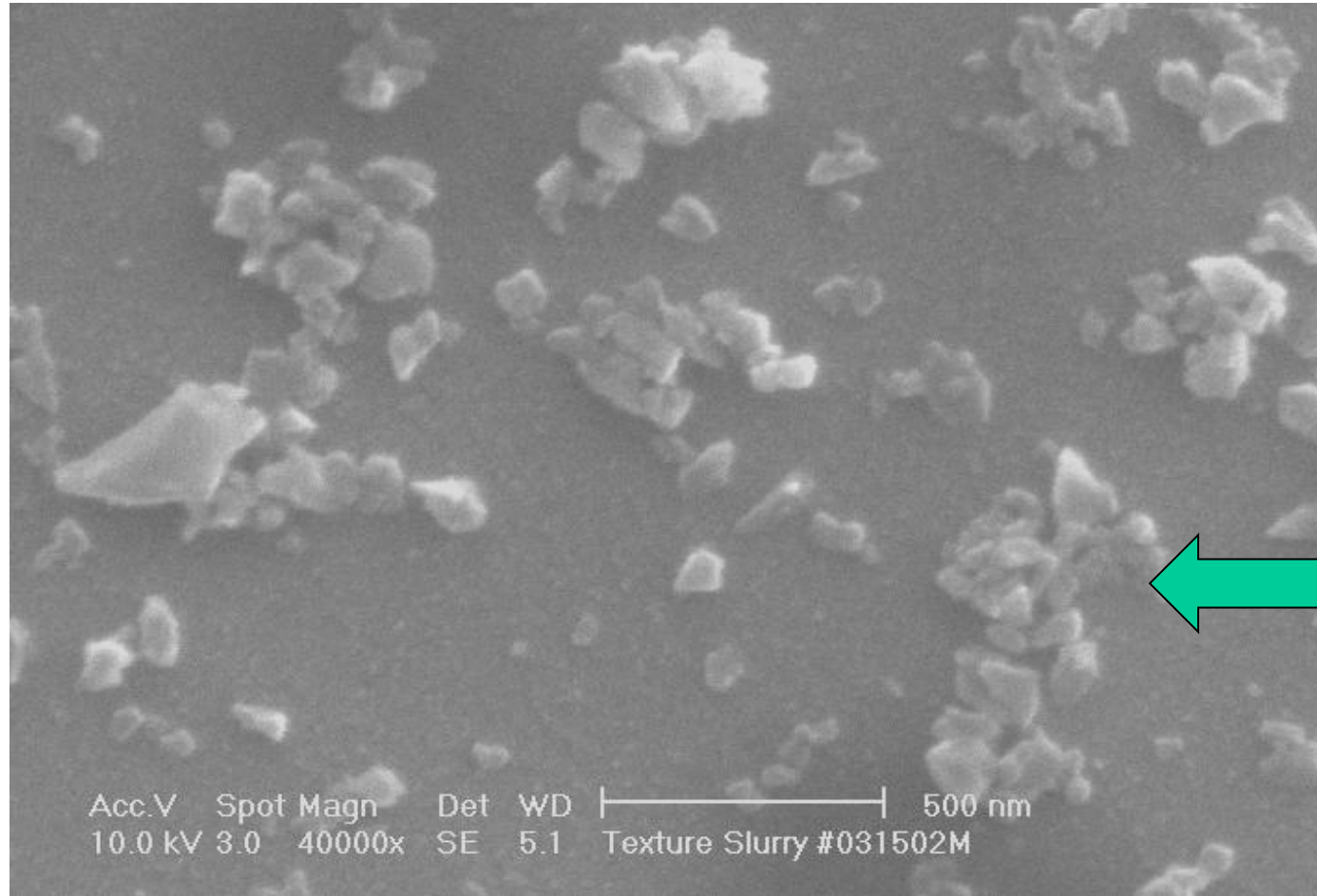
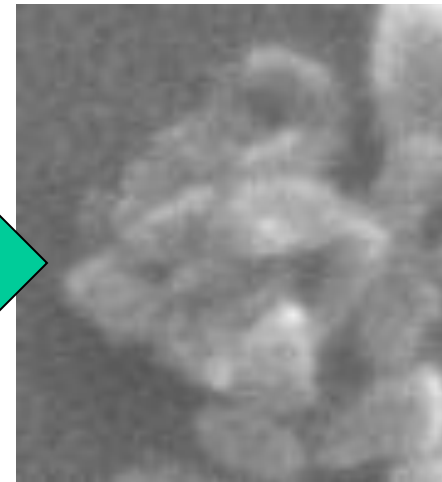

Texture-Induced hcp *c-axis* Alignment in Longitudinal Media

B. G. Demczyk

Texture Slurry

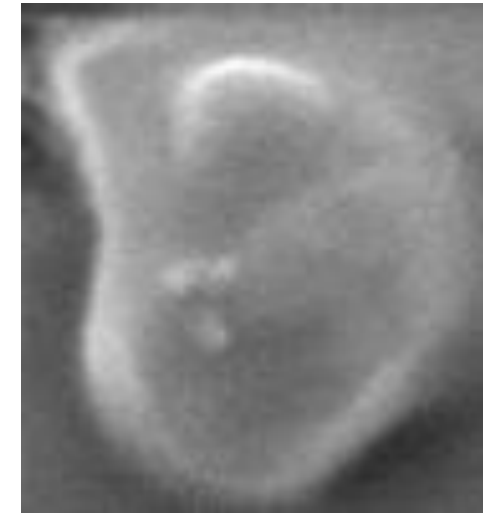


**Numerous Facets
Account for Fine
Texture Features**

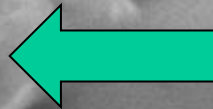


Texture Tape (with Slurry&Coolant)

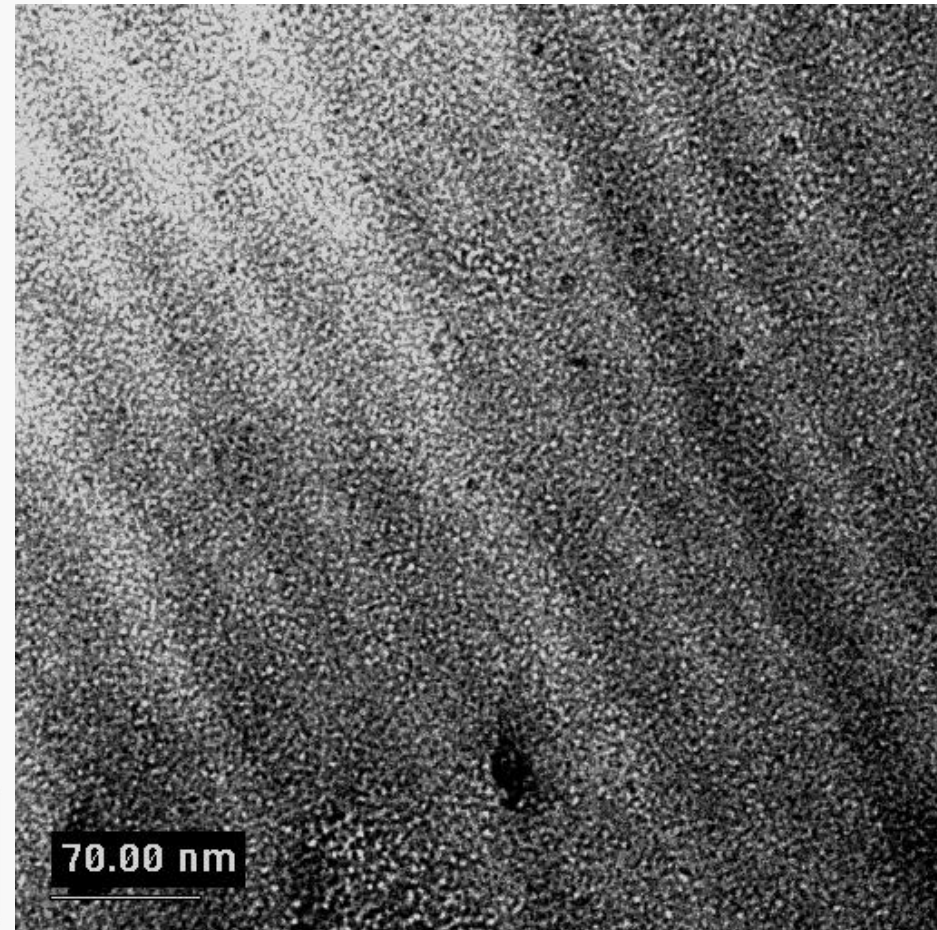
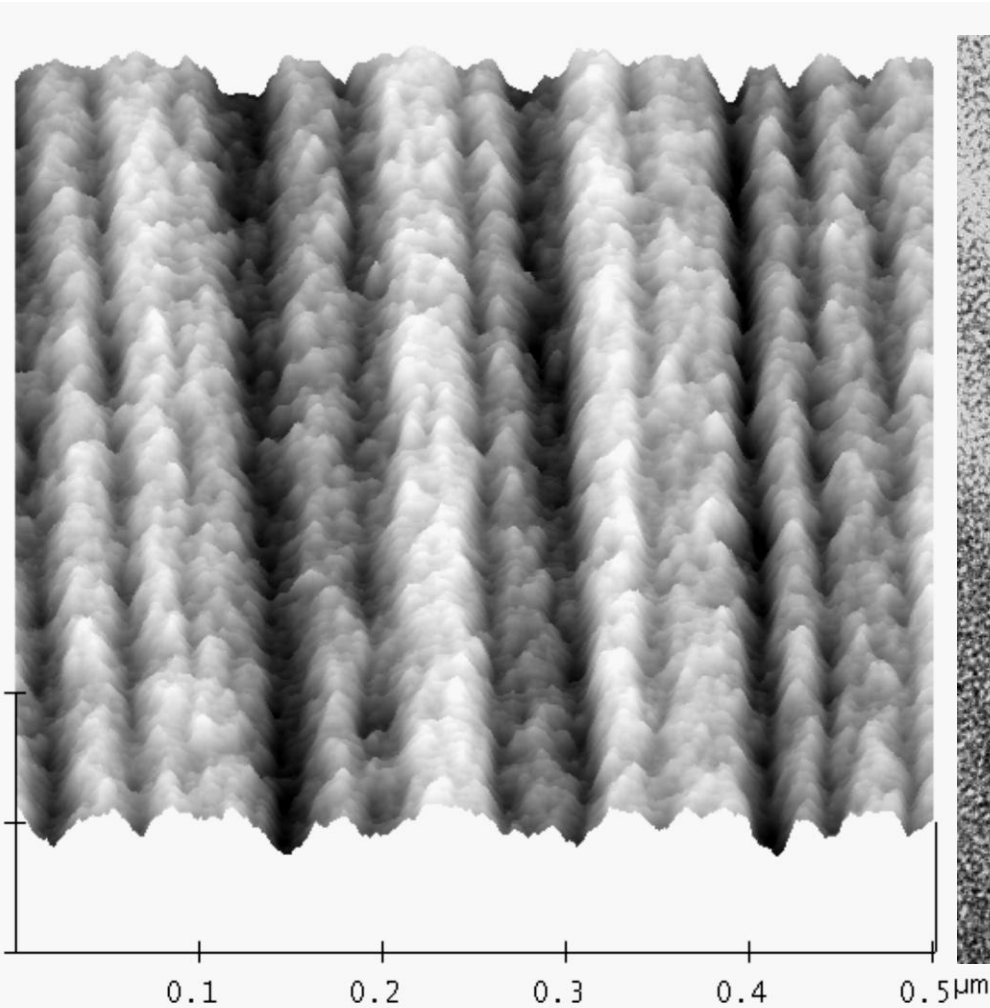
**Coolant
“Encapsulates”
Diamond Particle
Aggregate**



Acc.V Spot Magn Det WD |-----| 2 μ m
2.00 kV 3.0 10000x SE 9.4 TX015 + Slurry - Interface

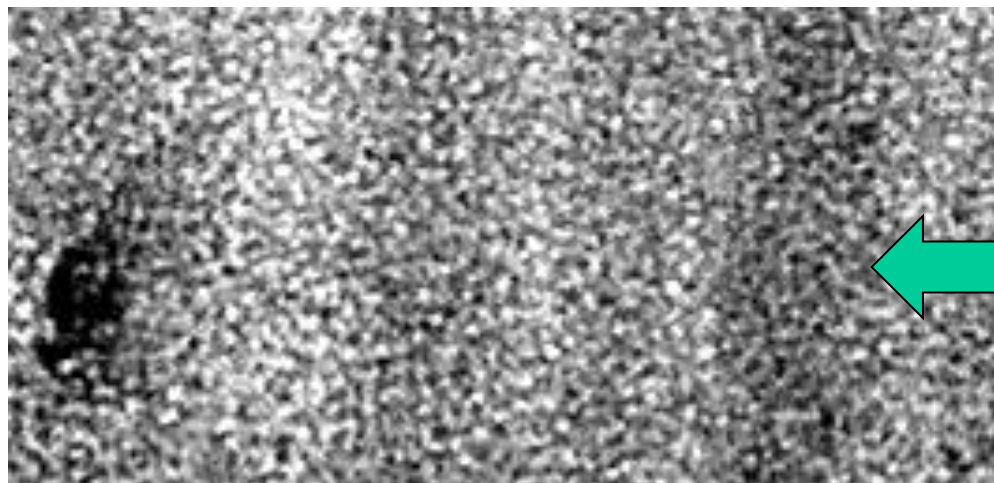


Textured NiP Substrate



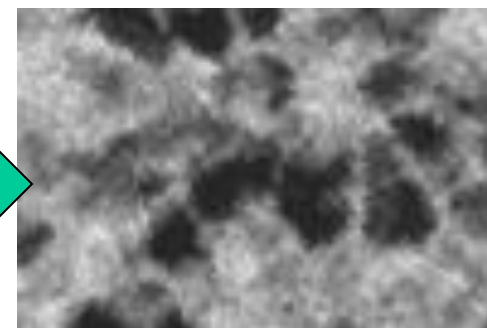
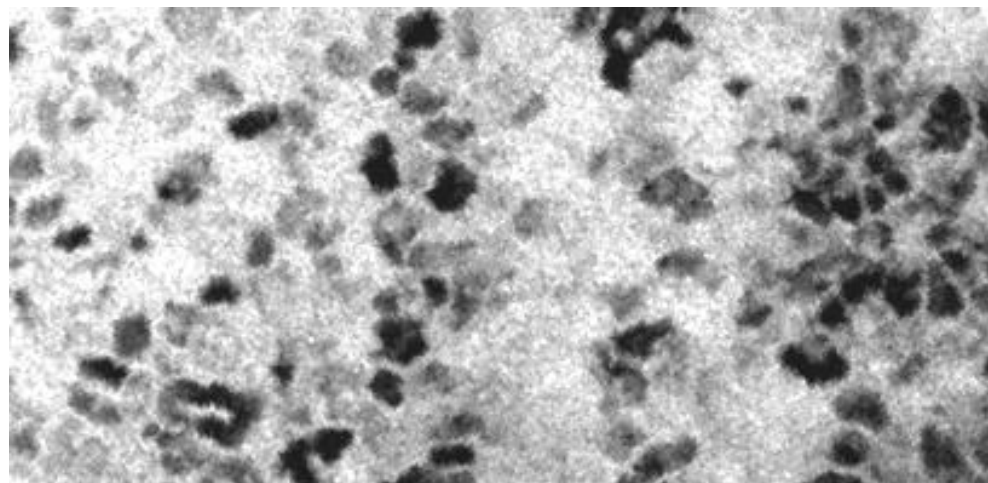
NiP-plated layer is “amorphous”

Textured NiP Substrate & Finished Disk

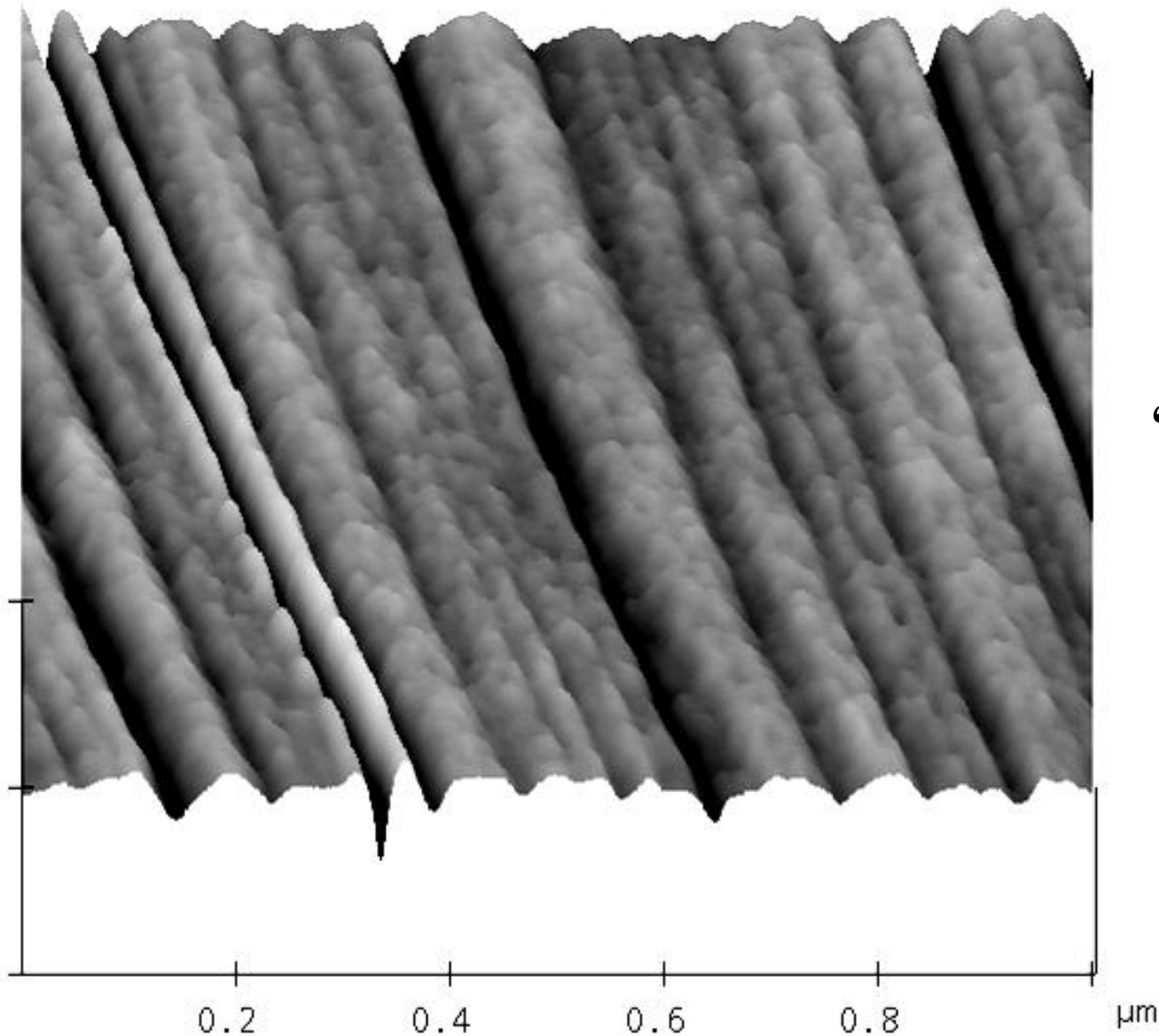


**As many as 5+
Grains per
“Texture Groove”**

70.00 nm

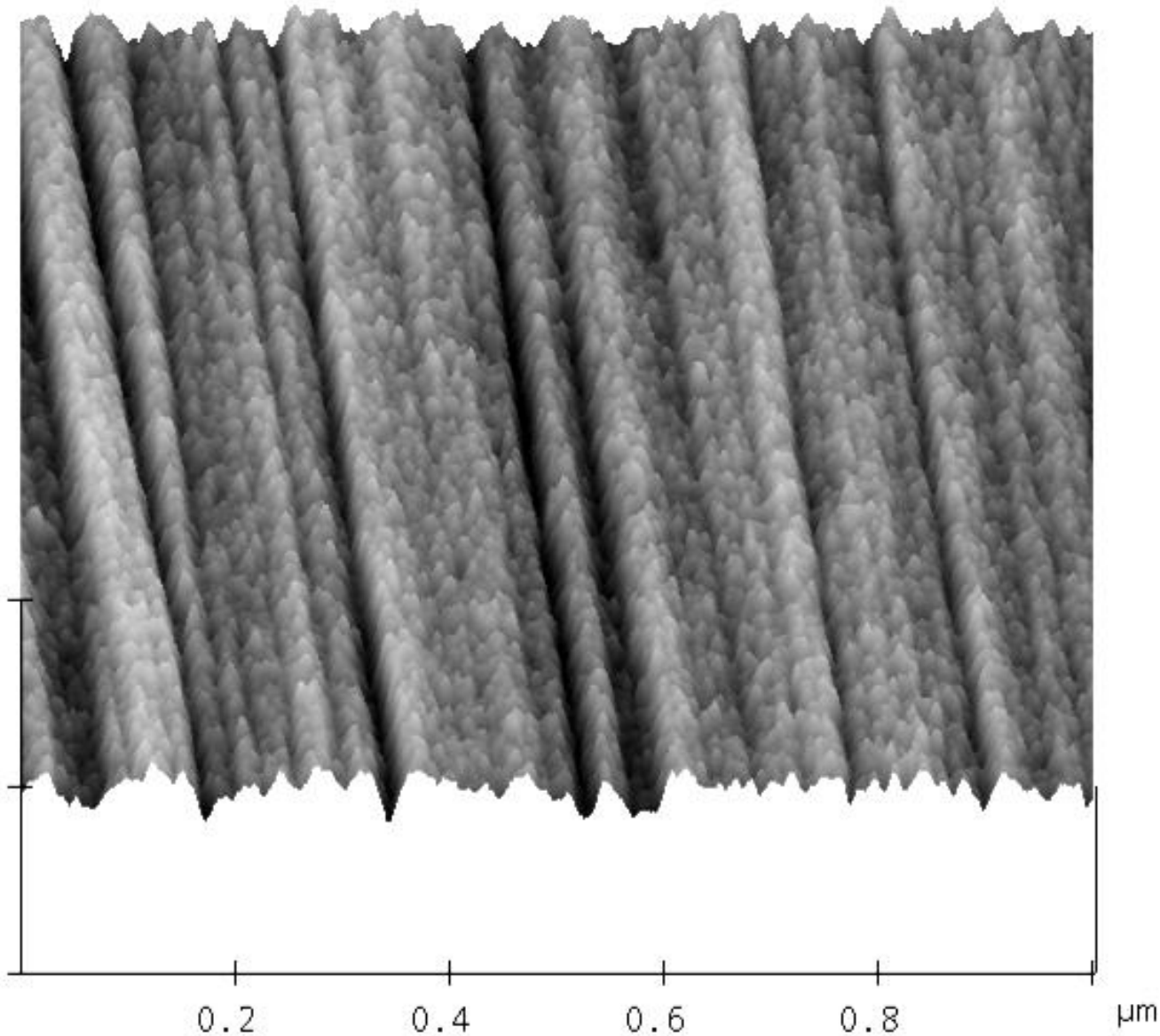


Finished Disk (OR=1.2; $R_a = 0.40$ nm)



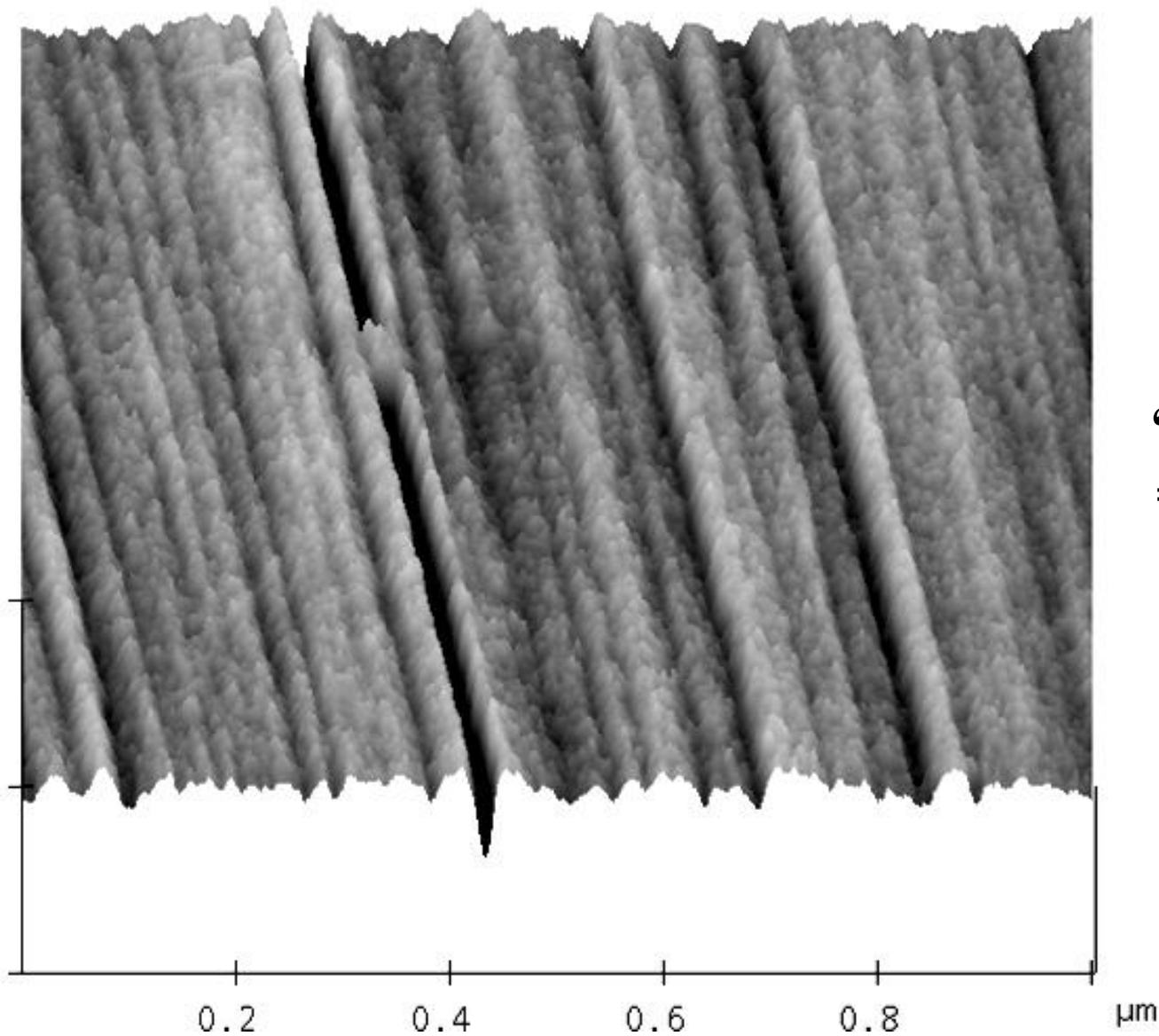
**“Line Density”
= “Low”**

Finished Disk (OR=1.6; $R_a = 0.42$ nm)



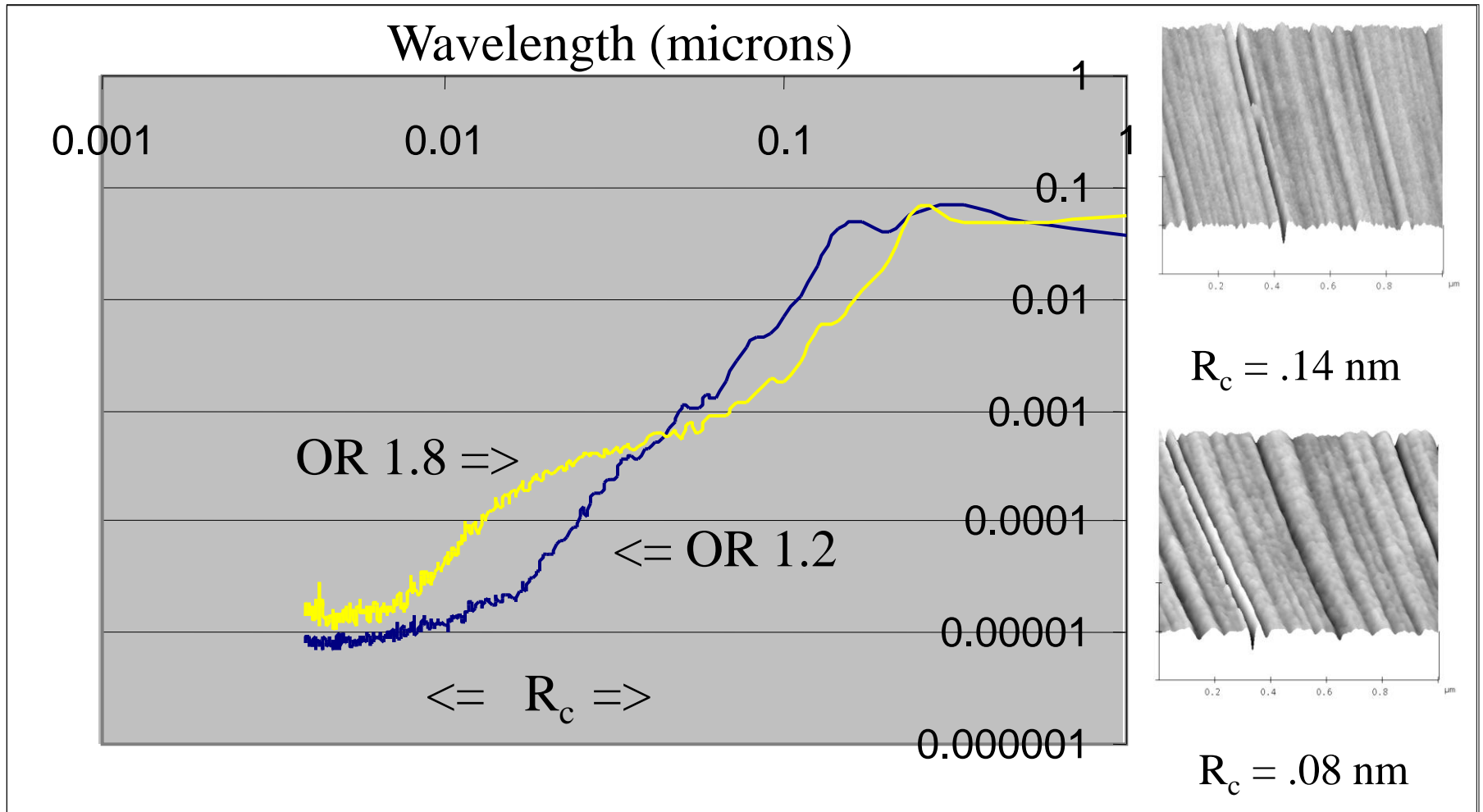
**“Line Density”
= “High”**

Finished Disk (OR=1.8; $R_a = 0.42$ nm)

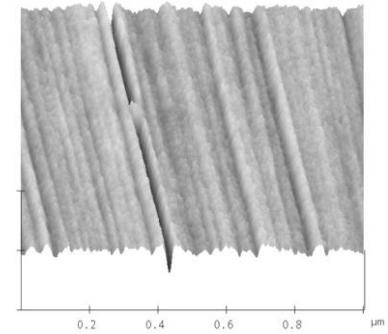
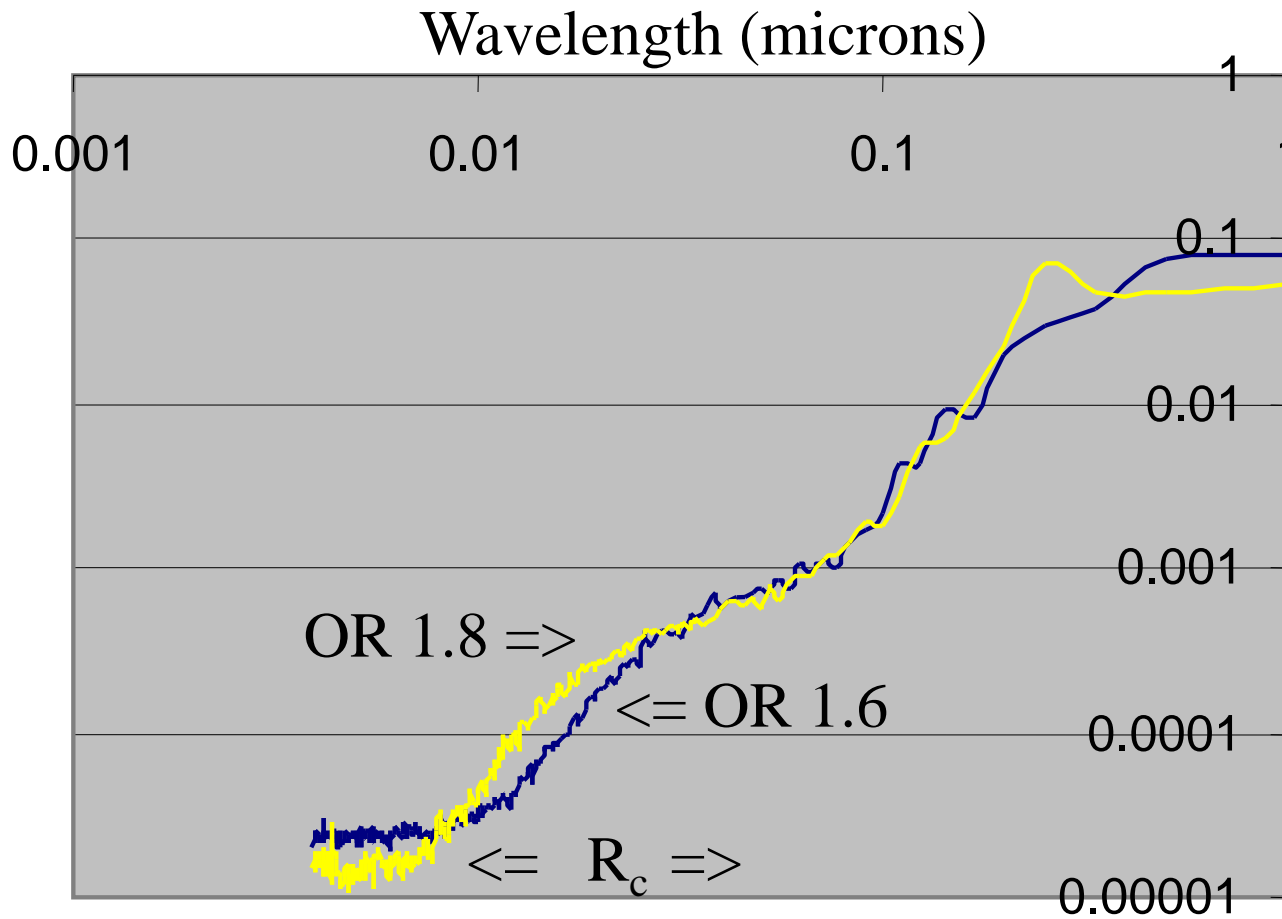


**“Line Density”
= “High(er)?”**

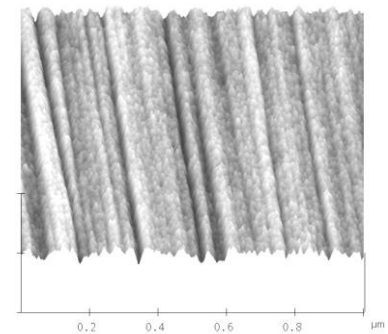
Circumferential PSD vs. OR ("Smooth" Disks)



Circumferential PSD vs. OR ("Smooth" Disks)

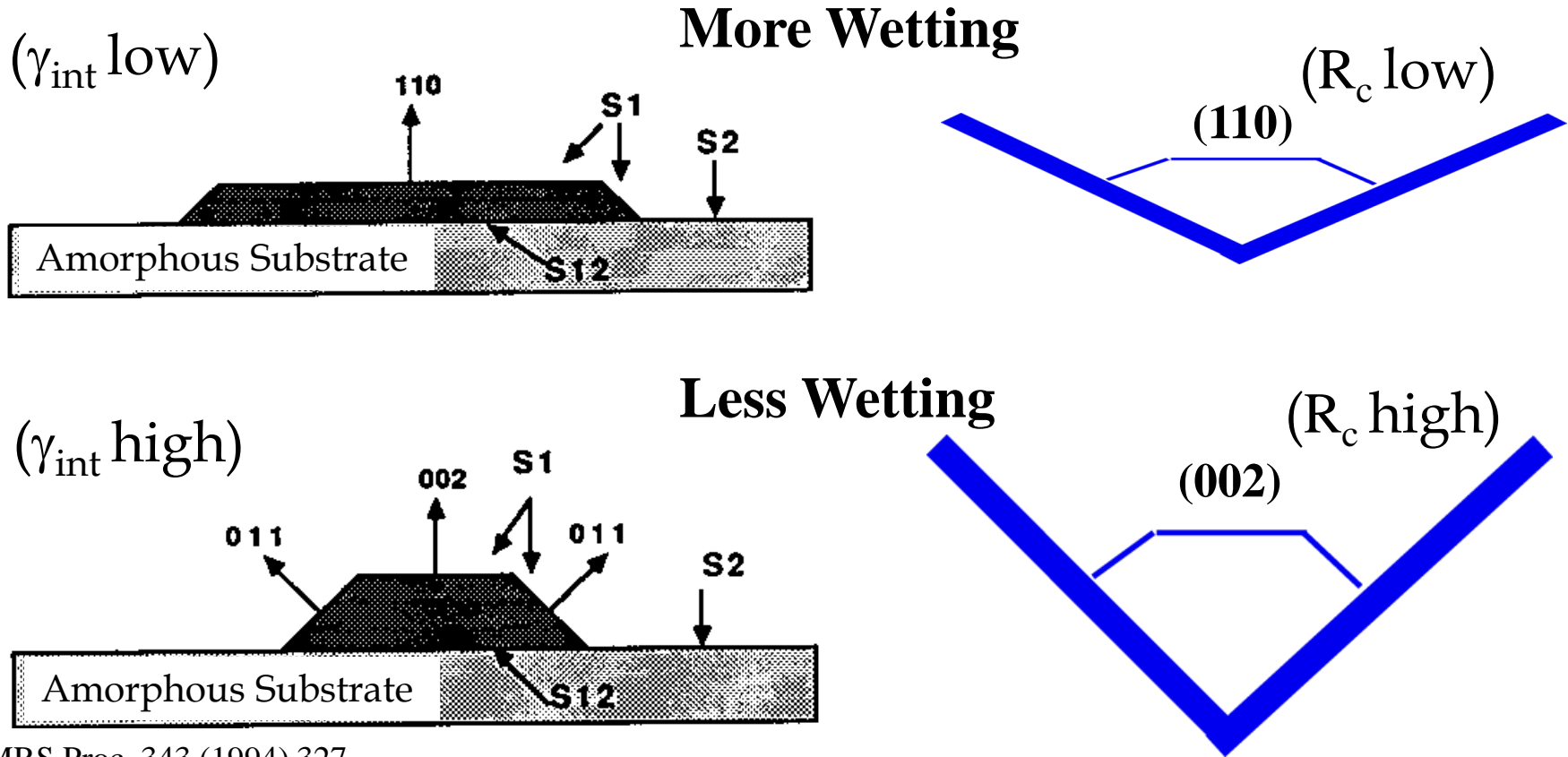


$R_c = .14 \text{ nm}$



$R_c = .12 \text{ nm}$

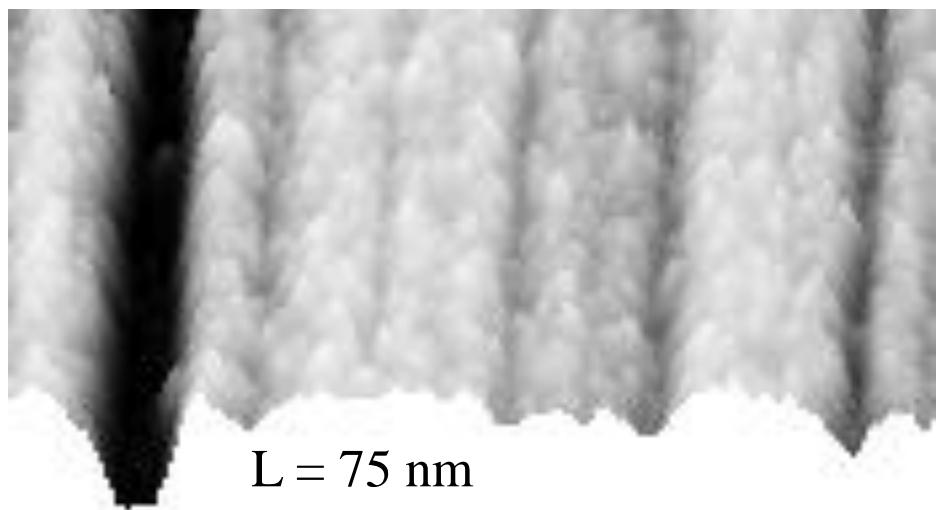
Growth - Cr Surface Energetics



MRS Proc. 343 (1994) 327.

Higher (R_c) “locks in” Cr(002) \Rightarrow Co(11.0) to reduce surface energy.

C-axis Distribution ($R_a = 0.8$, $OR = 1.4$)



$L = 75 \text{ nm}$

Circumferential

Radial

$\langle 200 \rangle$ random in-plane

$[200]$ or $[110]$

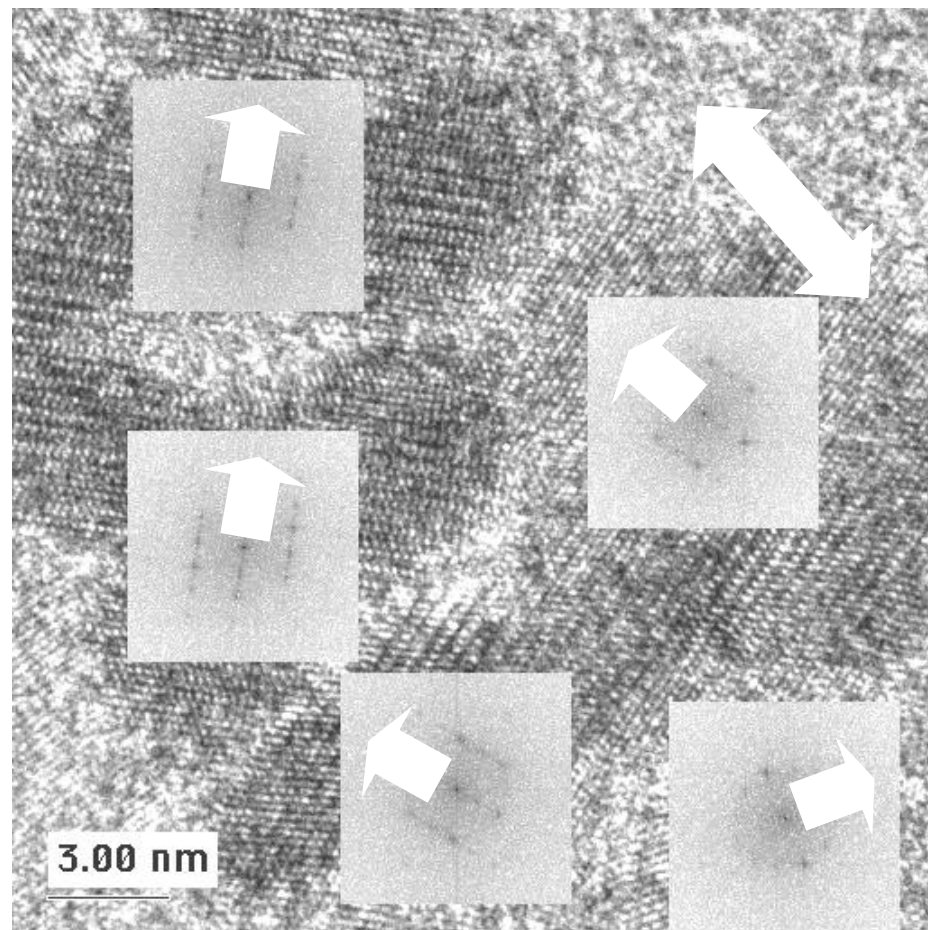
$\langle 200 \rangle$
"locked"

"locked"

$$R_a/L = 0.01$$

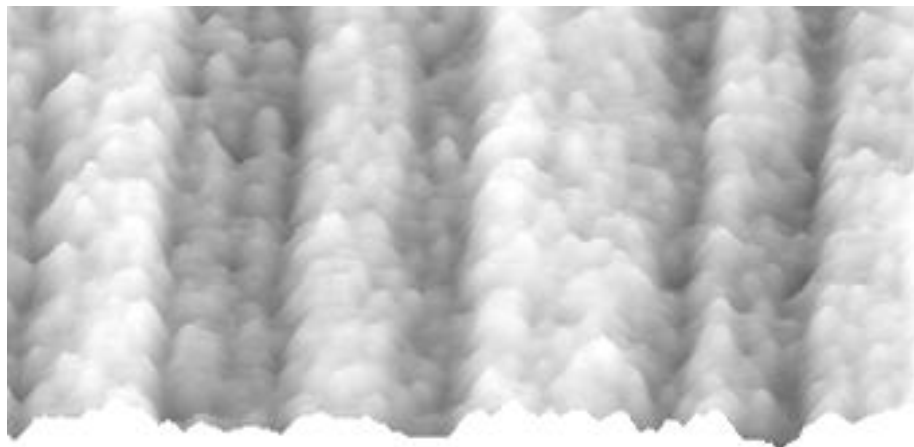
$$R_c/R_a = 0.36$$

Smaller L means more $\langle 200 \rangle$ "locked"



c-axes **random in-plane**

C-axis Distribution ($R_a = 0.4$, $OR = 1.7$)



$L = 75 \text{ nm}$

Circumferential

Radial

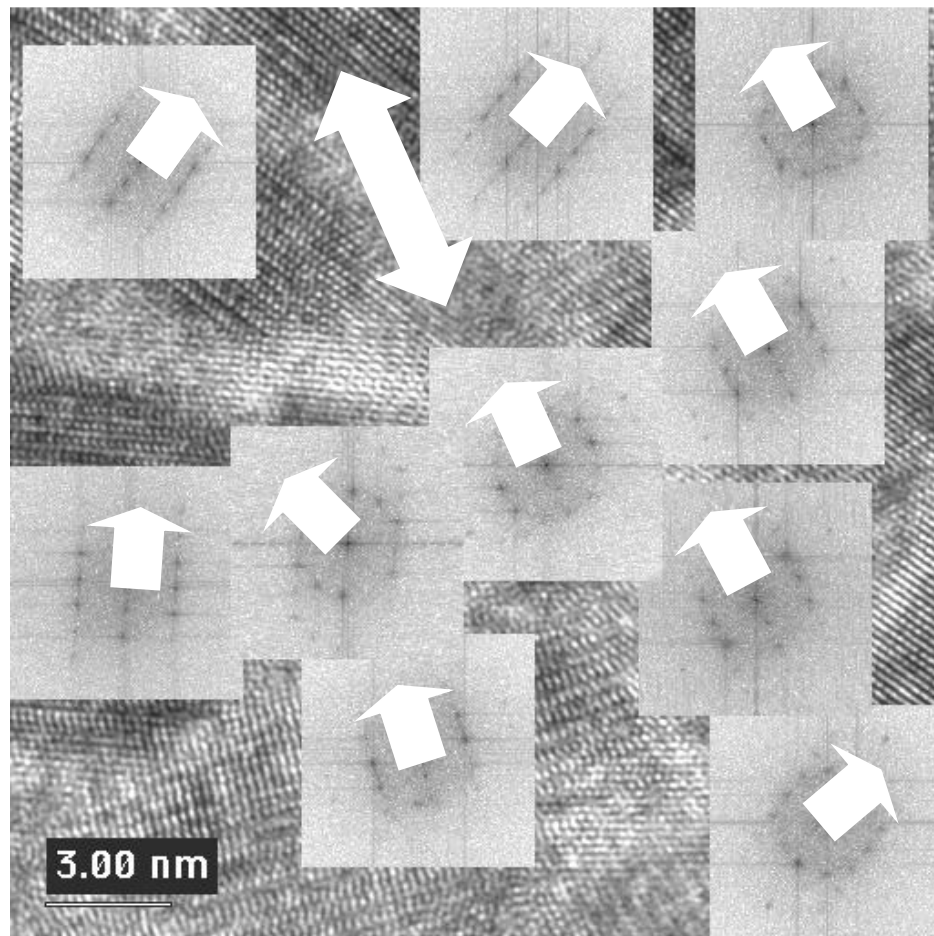
$\langle 200 \rangle$ random in-plane

$[200]$
"locked"

$\langle 200 \rangle$
"locked"

$$R_a/L = 0.005$$

$$R_c/R_a = 0.42$$



c-axes aligned in-plane

Summary

- 2D R_a alone is not sufficient to describe “smooth” ($R_a < 0.4$ nm) surfaces
 - “Line Density” too arbitrary a metric
 - Suffers from poor counting statistics (~ 10 's)
 - Does not explain *c-axis* alignment
- R_c more completely characterizes texture
 - Better sampling statistics (~ 100 's)
 - Gauges tendency towards *c-axis* alignment

Challenges

- Distinguishing disks with Δ OR less than ≤ 0.1
- Characterizing “ultrasmooth” ($R_a < 0.3$ nm) surfaces
- => May require higher **resolution** (not magnification) imaging and/or fractal dimensioning